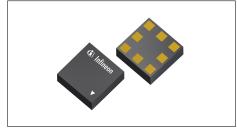


Low Resistance SPDT Antenna Aperture Switch

Features

- SPDT designed for high-linearity antenna aperture switching and RF tuning applications
- Ultra low R_{ON} resistance of 0.59 Ω at each port in ON state
- Low C_{OFF} capacitance of 270 fF at each port in OFF state
- > 40 V RF voltage OFF state handling
- Low harmonic generation
- Supply voltage range: 1.65 to 3.6 V
- Small form factor 1.1 mm x 1.1 mm
- RoHS and WEEE compliant package



1.1 x 1.1 mm²

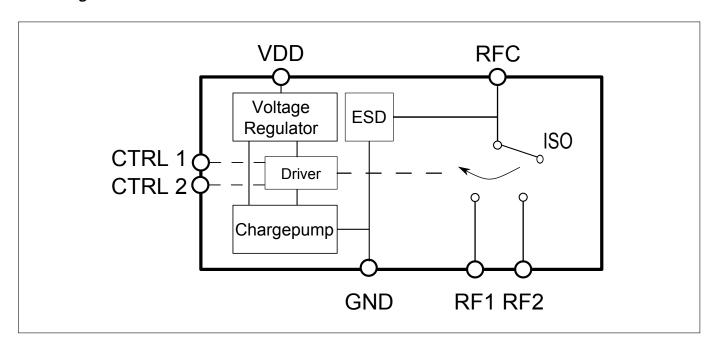
Application

- Impedance Tuning
- Antenna Tuning
- Inductance Tuning
- Tunable Filters

Product Validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Block diagram



Low Resistance SPDT Antenna Aperture Switch



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1

Low Resistance SPDT Antenna Aperture Switch

Features

1 Features

- SPDT designed for high-linearity antenna aperture switching and RF tuning applications
- Ultra low $R_{\rm ON}$ resistance of 0.59 Ω at each port in ON state
- Low C_{OFF} capacitance of 270 fF at each port in OFF state
- > 40 V RF voltage OFF state handling
- Low harmonic generation
- GPIO control interface including 4 control states
- Supply voltage range: 1.65 to 3.6 V
- No RF parameter change within supply voltage range
- Small form factor 1.1 mm x 1.1 mm
- Suitable for EDGE/ CDMA/WCDMA/ C2K/ LTE Applications
- RoHS and WEEE compliant package







Description

The BGSA12UGL8 is a versatile Single Pole Double Throw (SPDT) RF antenna aperture switch optimized for low C_{OFF} as well as low R_{ON} enabling applications up to 6.0 GHz. This single supply chip integrates with a 2 bits control logic featuring also a low current standby mode. Unlike GaAs technology, the 0.1 dB compression point exceeds the switch maximum input power level, resulting in linear performance at all signal levels and external DC blocking capacitors at the RF ports are only required if DC voltage is applied externally. Due to its very high RF voltage ruggedness, it is suited for switching any reactive devices such as inductors and capacitors in RF matching circuits without significant losses in quality factors.



Product Name	Marking	Package
BGSA12UGL8	A	TSLP-8-1

Low Resistance SPDT Antenna Aperture Switch



Maximum Ratings

2 Maximum Ratings

Table 1: Maximum Ratings, Table I at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol		Value	es	Unit	Note / Test Condition	
		Min.	Min. Typ.				
Frequency Range	f	0.4	-	T -	GHz	1)	
Supply voltage ²⁾	V_{DD}	-0.5	-	6	V	only for infrequent and short duration time periods	
Storage temperature range	T_{STG}	-55	-	150	°C	-	
RF input power	P _{RF_max}	-	-	41	dBm	Pulsed RF input duty cycle of 25% and 4620 µs in ON-state, measured per 3GPP TS 45.005, test condition schematic in Fig. 2 and Fig. 3.	
RF voltage	V _{RF_max}	-	-	50	V	Short term peaks (1 μ s in 0.1 % duty cycle), exceeding typical linearity, R_{ON} and C_{OFF} parameters, in Isolation mode, test condition schematic in Fig. 1	
ESD capability, CDM ³⁾	V _{ESD,CDM}	-1	_	+1	kV	_	
ESD capability, HBM ⁴⁾	V _{ESD,HBM}	-1	-	+1	kV		
ESD capability, system level (RF port) 5)	V _{ESD,ANT}	-8	-	+8	kV	RFx vs system GND, with 27 nH shunt inductor	
Junction temperature	TJ	-	-	125	°C	-	
Maximum DC-voltage on RF-Ports and RF- Ground	V_{RFDC}	0	-	0	V	No DC voltages allowed on RF- Ports	
Control Voltage Levels	V_{CTRL}	-0.7	-	3.3	V	-	

¹⁾ Switch has a low-pass response. For higher frequencies, losses have to be considered for their impact on thermal heating. The DC voltage at RF ports V_{RFDC} has to be 0 V.

Warning: Stresses above the max. values listed here may cause permanent damage to the device. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Exposure to conditions at or below absolute maximum rating but above the specified maximum operation conditions may affect device reliability and life time. Functionality of the device might not be given under these conditions.

²⁾ Note: Consider potential ripple voltages on top of V_{DD} . Including RF ripple, V_{DD} must not exceed the maximum ratings: $V_{DD} = V_{DC} + V_{RIPPLE}$.

³⁾ Field-Induced Charged-Device Model JS-002-2014. Simulates charging/discharging events that occur in production equipment and processes. Potential for CDM ESD events occurs whenever there is metal-to-metal contact in manufacturing.

⁴⁾ Human Body Model ANSI/ESDA/JEDEC JS-001 ($R = 1.5 \text{ k}\Omega$, C = 100 pF).

⁵⁾ IEC 61000-4-2 ($R = 330 \,\Omega$, $C = 150 \,\text{pF}$), contact discharge.



Maximum Ratings

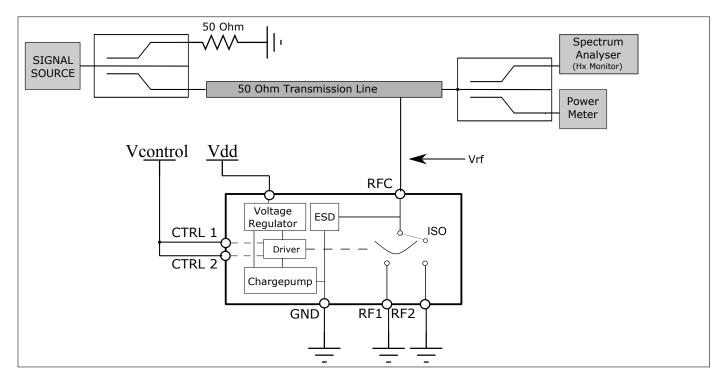


Figure 1: RF operating voltage measurement configuration - OFF mode

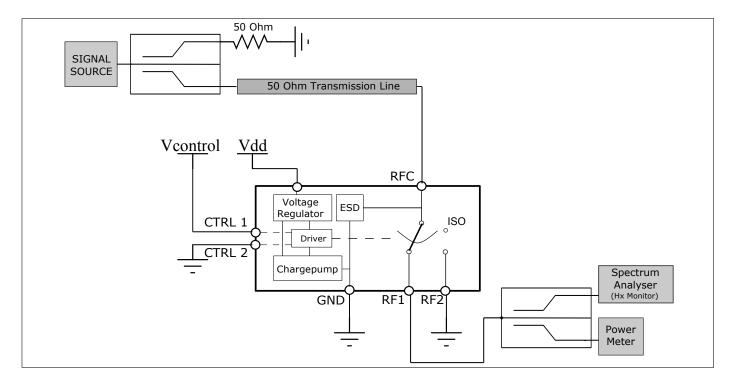


Figure 2: RF operating and Harmonics generation voltage measurement configuration - RF1 ON mode



Maximum Ratings

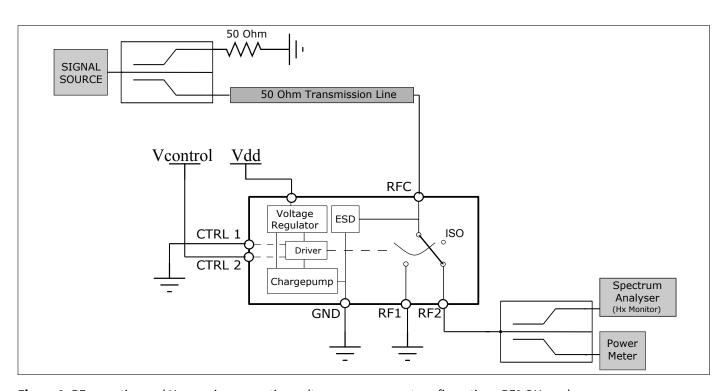


Figure 3: RF operating and Harmonics generation voltage measurement configuration - RF2 ON mode

Low Resistance SPDT Antenna Aperture Switch



DC Characteristics

3 DC Characteristics

Table 2: Operation Ranges

Parameter	Symbol		Values		Unit	Note / Test Condition	
		Min. Typ. Max.		Max.			
Supply voltage	V_{DD}	1.65	2.8	3.6	V	-	
Supply current	I _{DD}	45	60	350 ¹	μΑ	¹ T _A = 85 °C,	
						P_{IN} = 40 dBm, ON mode	
Supply current in low power mode	I _{DD,LP}	_	_	1	μΑ	$T_{\rm A} = -40 ^{\circ} \rm C+85 ^{\circ} \rm C,$	
						$V_{\rm DD} = 1.65 - 3.6 \rm V$	
Control voltage low	$V_{\rm CTRL,low}$	0	_	0.45	V	-	
Control voltage high	V _{CTRL,high}	1.2	1.8	2.85	V	$V_{\mathrm{CTRL,high}} \ll V_{\mathrm{DD}}$	
Control current low	I _{CTRL,low}	-1	0	1	μΑ	-	
Control current high	I _{CTRL,high}	-1	0	4	μΑ	$V_{\mathrm{CTRL,high}} \ll V_{\mathrm{DD}}$	
						1MΩ Pull-Down resistor at	
						Control Pins	
Ambient temperature	T_{A}	-40	25	85	°C	-	
RF switching time	t _{ST}	4.7	5	5.5	μs	$P_{\rm IN}$ = 0 dBm, Z_0 = 50Ω ,	
						<i>T</i> _A = −40 °C +85 °C	
						$V_{\rm DD} = 1.65 - 3.6 \rm V$	
Startup time	t_{PUP}	5	6	7	μs	Ref. Fig. 4 and Fig. 5	

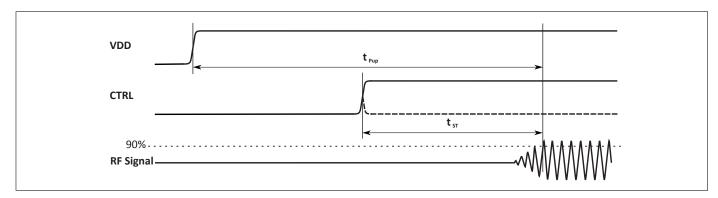


Figure 4: Power Up settling time and switching time

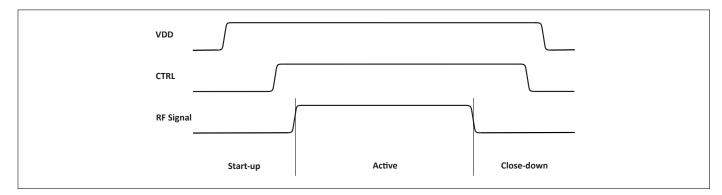


Figure 5: Timing of Control and RF signals for valid operation

Low Resistance SPDT Antenna Aperture Switch



RF Small Signal Characteristics

4 RF Small Signal Characteristics

Parameter	Symbol	Values		Unit	STATE / Notes		
		Min.	Тур.	Max.			
Frequency range	f	0.4		6.0	GHz		
RF1 or RF2 to RFc	R _{ON}	0.5	0.59	0.7	Ω	V -165 26V	
ON DC resistance						$V_{\rm DD} = 1.65 - 3.6 \text{ V},$ - $T_{\rm A} = 25 ^{\circ}\text{C},$	
RF1 or RF2 to RFc	R _{OFF}	38	42.5	45	kΩ	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
OFF DC resistance						Four-terminal sensing method	
RF1 or RF2 to RFc	C _{OFF}	235	270	305	fF	$V_{\rm DD}$ = 1.65 - 3.6 V, $T_{\rm A}$ = 25 °C,	
OFF capacitance						extracted from Isolation (S21) mea-	
						surement $Z_0 = 50 \Omega$	

Table 3: RF electrical parameters

Insertion Loss: RF1 to RFc or RF2 to RFc (SPDT mode) (1,2,3)

Parameter	Symbol		Values		Unit	STATE / Notes
		Min.	Тур.	Max.		
698 - 960 MHz		0.07	0.14	0.25	dB	
961 - 1710 MHz		0.20	0.26	0.39	dB	
1711 - 1910 MHz	<i>IL</i> _{SPDT}	0.24	0.31	0.45	dB	$V_{\rm DD} = 1.65 - 3.6 \text{V}, Z_0 = 50 \Omega,$
1911 - 2169 MHz		0.33	0.39	0.55	dB	$T_{\Delta} = -40 ^{\circ}\text{C} + 85 ^{\circ}\text{C}$
2170 - 2690 MHz		0.40	0.48	0.65	dB	- 1A- 40 C183 C
3300 - 3800 MHz		0.69	0.88	1.25	dB	
3801 - 4800 MHz		0.69	1.2	1.75	dB	
4801 - 6000 MHz		1.3	1.9	2.3	dB	
Isolation: RF1 to RFc or RF2 to	RFc (SPDT mo	de) ^(1,2,3)		•		
698 - 960 MHz		23	24	25	dB	
961 - 1710 MHz	150	15.5	17	18	dB	
1711 - 1910 MHz	- ISO _{SPDT}	14.5	16	17	dB	
1911 - 2169 MHz		14	15	16	dB	$V_{\rm DD}$ = 1.65 - 3.6 V, Z_0 = 50Ω ,
2170 - 2690 MHz		12	13.5	15	dB	T _A = −40 °C+85 °C
3300 - 3800 MHz		9.5	11	12	dB	
3801 - 4800 MHz		9	10.5	11.5	dB	-
4801 - 6000 MHz		8	8.8	10.5	dB	

 $^{^{1)}}$ Valid for all RF power levels, no compression behavior $^{2)}$ SOLT-calibrated, $P_{\rm IN}$ = 0 dBm

³⁾On application board without any matching components

Low Resistance SPDT Antenna Aperture Switch



RF Small Signal Characteristics

Table 3: RF electrical parameters (continued)

Isolation: RFc to RFx (Isolation mode, no switch selection)^(1,2,3)

Parameter	Symbol	Symbol Value		lues Unit		STATE / Notes
		Min.	Тур.	Max.		
698 - 960 MHz		17	18	19	dB	
961 - 1710 MHz	150	10.5	11.5	12.5	dB	
1711 - 1910 MHz	ISO _{ISO}	10	11	12	dB	
1911 - 2169 MHz		9	10	11	dB	$VP_{DD} = 1.65 - 3.6 \text{ V}, Z_0 = 50 \Omega$
2170 - 2690 MHz		8	9	10	dB	T _A = −40 °C+85 °C
3300 - 3800 MHz		7	8	9	dB	
3801 - 4800 MHz		6.5	7.5	8.5	dB	
4801 - 6000 MHz		5.5	7	8.5	dB	
Isolation: RF1 to RF2 or RF2	to RF1 (SPDT me	ode) ^(1,2,3)	·	•	•	
698 - 960 MHz		19	21	23	dB	
961 - 1710 MHz	150	14	16	18	dB	
1711 - 1910 MHz	ISO _{SPDT}	13	15	17	dB	
1911 - 2169 MHz		12	14	16	dB	$V_{\rm DD} = 1.65 - 3.6 \text{V}, Z_0 = 50 \Omega,$
2170 - 2690 MHz		11	13	15	dB	T _A = −40 °C+85 °C
3300 - 3800 MHz		8	10	12	dB	
3801 - 4800 MHz		7	9	11	dB	
4801 - 6000 MHz		6	8	10	dB	
Isolation: RF1 to RF2 or RF2	to RF1 (Isolation	n mode, n	o switch so	election) ^{(1,2,3}	3)	
698 - 960 MHz		34	36	38	dB	
961 - 1710 MHz	150	25	27	29	dB	
1711 - 1910 MHz	ISO _{ISO}	23	25	27	dB	
1911 - 2169 MHz		21	23	25	dB	$V_{\rm DD} = 1.65 - 3.6 \mathrm{V}, Z_0 = 50 \Omega,$
2170 - 2690 MHz		18	20	22	dB	T _A = −40 °C+85 °C
3300 - 3800 MHz		14	16	18	dB	
3801 - 4800 MHz		12	14	16	dB	
4801 - 6000 MHz		10	12	14	dB	1

¹⁾ Valid for all RF power levels, no compression behavior

²⁾ SOLT-calibrated, $P_{\rm IN}$ = 0 dBm ³⁾ On application board without any matching components

Low Resistance SPDT Antenna Aperture Switch



RF Large Signal Parameter

5 RF Large Signal Parameter

Table 4: RF large signal specifications at T_A = 25 $^{\circ}$ C

Parameter	Symbol		Values		Unit	Note / Test Condition	
		Min.	Тур.	Max.			
Max. RF Operating Voltage	V _{RF_opr}	-	-	40	V	In Isolation mode, test condition schematic in Fig. 1 for H2/H3 < -40 dBm @ 50 Ω	
Max. RF Operating Power	V _{RF_pwr}	-	-	40	dBm	RF1 or RF2 in ON mode, test condition schematic in Fig. 2 or Fig. 3 for H2/H3 < -40 dBm @ 50Ω	
Harmonic Generation up to 12.7	5 GHz	'				ı	
All RF Ports - Second Order Harmonics	P _{H2}	95	105	-	dBc	25 dBm, 50Ω , $f_0 = 824 MHz$, test condition in Fig. 2 an Fig. 3	
All RF Ports - Third Order Harmonics	P _{H3}	110	120	-	dBc	25 dBm, 50Ω , $f_0 = 824 MHz$, test condition in Fig. 2 an Fig. 3	
All RF Ports - Second Order Harmonics	P _{H2}	80	90	-	dBc	36 dBm, 50Ω , $f_0 = 824 MHz$, test condition in Fig. 2 an Fig. 3	
All RF Ports - Third Order Harmonics	P _{H3}	90	100	-	dBc	36 dBm, 50Ω , $f_0 = 824 MHz$, test condition in Fig. 2 an Fig. 3	
All RF Ports - Third Order Harmonics	P _{H3}	90	100	-	dBc	36 dBm, 50 Ω , f_0 = 1800 MHz, test condition in Fig. 2 an Fig. 3	
All RF Ports - Second Order Harmonics	P _{H2}	95	105	-	dBc	25 dBm, 50 Ω , f_0 = 1800 MHz, test condition in Fig. 2 an Fig. 3	
All RF Ports - Third Order Harmonics	P _{H3}	110	120	-	dBc	25 dBm, 50 Ω , f_0 = 1800 MHz, test condition in Fig. 2 an Fig. 3	
All RF Ports - Second Order Harmonics	P _{H2}	80	90	-	dBc	36 dBm, 50 Ω , f_0 = 1800 MHz, test condition in Fig. 2 an Fig. 3	
Higher order harmonic products	P _{Hx}	105	_	-	dBc	25 dBm, 50 Ω	
Intermodulation Distortion IMD	2	•		•	·		
IIP2, low	IIP2 _L	110	114	_	dBm	UDO anditions talls 5	
IIP2, high	IIP2 _H	117	120	-	dBm	IIP2 conditions table 5	
Intermodulation Distortion IMD	3						
IIP3	IIP3	71	75	_	dBm	IIP3 conditions table 6	
SV LTE Intermodulation							
IIP3,SVLTE	IIP3 _{SV}	71	75	_	dBm	SV-LTE conditions table 7	

Low Resistance SPDT Antenna Aperture Switch



RF Large Signal Parameter

Table 5: IIP2 conditions table

Band	In-Band Frequency Blocker Frequency 1		Blocker Power 1 Blocker Frequency 2		Blocker Power 2
	[MHz]	[MHz]	[dBm]	[MHz]	[dBm]
Band 1 Low	2140	1950	20	190	-15
Band 1 High	2140	1950	20	4090	-15
Band 5 Low	881.5	836.5	20	45	-15
Band 5 High	881.5	836.5	20	1718	-15

Table 6: IIP3 conditions table

Band	In-Band Frequency Blocker Frequency 1		Blocker Power 1	Blocker Frequency 2	Blocker Power 2
	[MHz]	[MHz]	[dBm]	[MHz]	[dBm]
Band 1	2140	1950	20	1760	-15
Band 5	881.5	836.5	20	791.5	-15

Table 7: SV-LTE conditions table

Band	In-Band Frequency Blocker Frequency 1		Blocker Power 1	Blocker Frequency 2	Blocker Power 2
	[MHz]	[MHz]	[dBm]	[MHz]	[dBm]
Band 5	872	827	23	872	14
Band 13	747	786	23	747	14
Band 20	878	833	23	2544	14

Low Resistance SPDT Antenna Aperture Switch



Application Information

6 Logic Table

Table 8: Logic Table

CTRL 1	CTRL 2	Mode
0	0	Low power mode
0	1	RF2 connected to RFC
1	0	RF1 connected to RFC
1	1	Isolation mode (no switch selection)

7 Application Information

Pin Configuration and Function

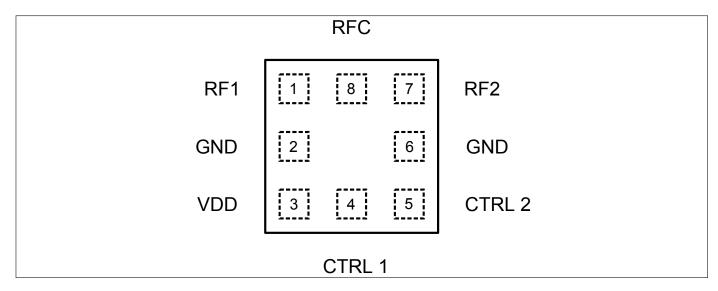


Figure 6: BGSA12UGL8 Pin Configuration (top view)

Table 9: Pin Definition and Function

Pin No.	Name	Function
1	RF1	RF port
2	GND	Ground
3	VDD	DC Supply Voltage
4	CTL1	Control Pin 1
5	CTL2	Control Pin 2
6	GND	Ground
7	RF2	RFport
8	RFC	Common RF



Package Information

8 Package Information

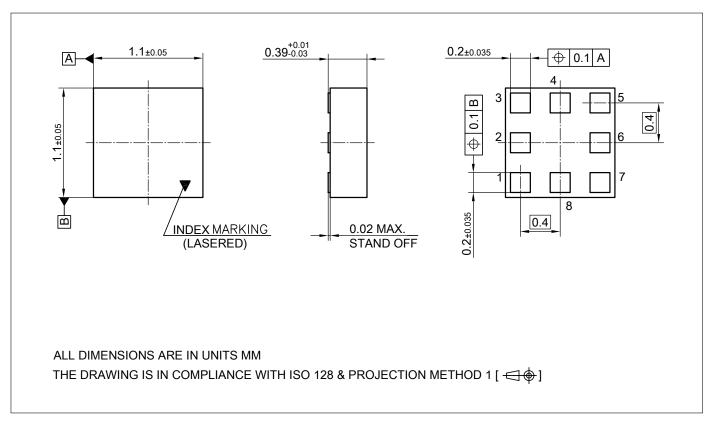


Figure 7: TSLP-8-1 Package Outline (top, side and bottom views)

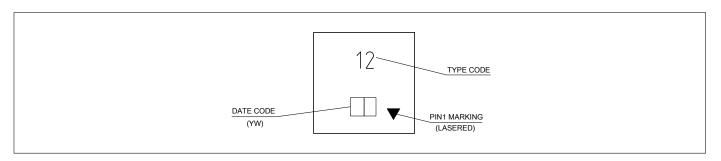


Figure 8: Marking Specification (top view): Date code digits Y and W defined in Table 10/11

Low Resistance SPDT Antenna Aperture Switch



Package Information

Table 10: Year date code marking - digit "Y"

				-6	
Year	"Y"	Year	"Y"	Year	"Y"
2000	0	2010	0	2020	0
2001	1	2011	1	2021	1
2002	2	2012	2	2022	2
2003	3	2013	3	2023	3
2004	4	2014	4	2024	4
2005	5	2015	5	2025	5
2006	6	2016	6	2026	6
2007	7	2017	7	2027	7
2008	8	2018	8	2028	8
2009	9	2019	9	2029	9

Table 11: Week date code marking - digit "W"

Week	"W"	Week	"W"	Week	"W"	Week	"W"	Week	"W"
1	Α	12	N	23	4	34	h	45	V
2	В	13	Р	24	5	35	j	46	x
3	С	14	Q	25	6	36	k	47	у
4	D	15	R	26	7	37	l	48	z
5	E	16	S	27	a	38	n	49	8
6	F	17	Т	28	b	39	р	50	9
7	G	18	U	29	c	40	q	51	2
8	Н	19	V	30	d	41	r	52	3
9	J	20	W	31	e	42	s	53	M
10	K	21	Υ	32	f	43	t		
11	L	22	Z	33	g	44	u		

Low Resistance SPDT Antenna Aperture Switch



Package Information

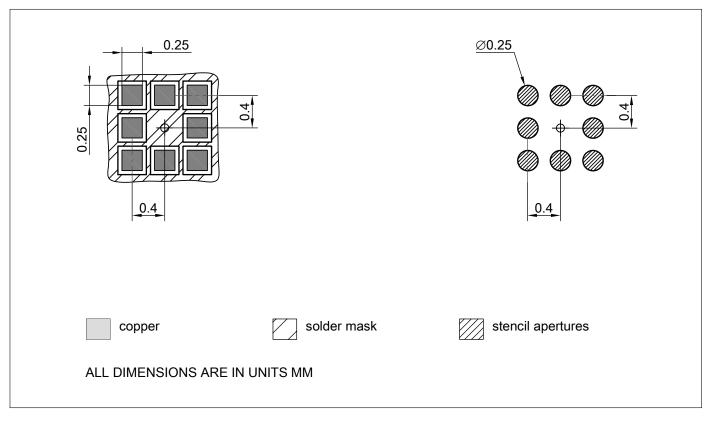


Figure 9: Footprint Recommendation

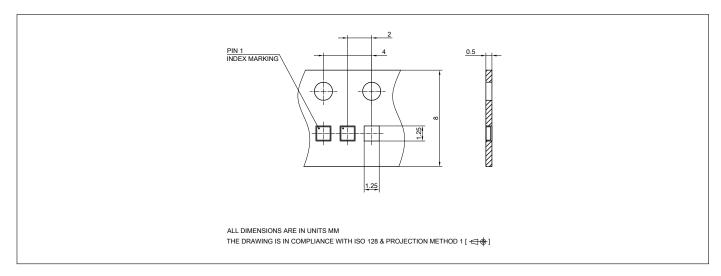


Figure 10: TSLP-8-1 Carrier Tape

Revision History				
Creation of document Revision 2.3, 2019-08-13				
Page or Item	Subjects (major changes since previous revision)			
6	Updated Vddmin to 1.65V			

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